## Search Notes



Application/Cont	rol No.	Applicant(s)/Patent Under Reexamination
10817145		SCHATZ ET AL.
Examiner		Art Unit
Thomas, Mia M		2609

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES				
Search Notes	Date	Examiner		
(382/144) text and image search-see search notes	02/14/07	mmt		
(430/30) text and image search-see search notes	02/14/07	mmt		
(382/144) image and numerical search-see search history (consulted A. Johns (2624) and B. Werner (2624)	02/26/07	mmt		
"Demonstration of Damage Free Mask Repair"; Liang, Ted 2002 (SPIE)	02/12/07	mmt		
Palm Intranet Text Search-see attached printouts	02/12/07	mmt		
Updated searchimage, text and keyword search382/144, 141, 100; 430/5, 30	04/08/08	mmt		
Internet Text Search-Google (see attached search history)	04/08/08	mmt		
updated searchsee attached search history	10/25/08	mmt		

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